

#### **TOSHIBA Multi Chip Discrete Device**

# HN7G02FU

Power Management Switch Application, Inverter Circuit Application, Driver Circuit Application and Interface Circuit Application.

Q1 (transistor): RN2110 Equivalent

Q2 (MOS-FET): 2SK1830 Equivalent

#### Q1 (Transistor) Absolute Maximum Ratings $(Ta = 25^{\circ}C)$

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V <sub>CBO</sub>	-50	V
Collector-emitter voltage	V <sub>CEO</sub>	-50	V
Emitter-base voltage	V <sub>EBO</sub>	-5	V
Collector current	Ι <sub>C</sub>	-100	mA

#### Q2 (MOS-FET) Absolute Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Drain-source voltage	V <sub>DS</sub>	20	V
Gate-source voltage	V <sub>GSS</sub>	10	V
DC drain current	Ι <sub>D</sub>	50	mA

### Q1, Q2 Common Ratings (Ta = 25°C)

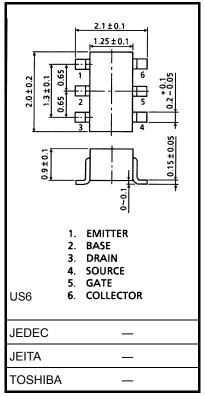
Characteristics	Symbol	Rating	Unit
Collector power dissipation	P <sub>C</sub> (Note 1)	200	mW
Junction temperature	Tj	150	°C
Storage temperature range	T <sub>stg</sub>	-55~150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum Equivalent Circuit (top view) ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling

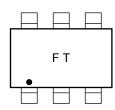
Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

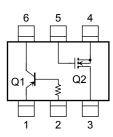
Note 1: Total rating



Weight: g (typ.)

#### Marking





Unit: mm

## Q1 (Transistor) Electrical Characteristics (Ta = 25°C)

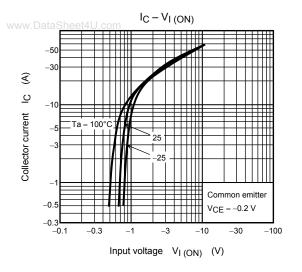
ww.DataSheet4L.com Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	$V_{CB}=-50~V,~I_{E}=0$	_		-100	nA
Emitter cut-off current	I <sub>EBO</sub>	$V_{EB} = -5 \text{ V}, \text{ I}_{C} = 0$	_	_	-100	nA
DC current gain	h <sub>FE</sub>	$V_{CE} = -5 V, I_{C} = -1 mA$	120	_	400	
Collector-emitter saturation voltage	V <sub>CE (sat)</sub>	$I_{C} = 5 \text{ mA}, I_{B} = -0.25 \text{ mA}$	_	-0.1	-0.3	V
Input resistor	R1	—	3.29	4.7	6.11	kΩ

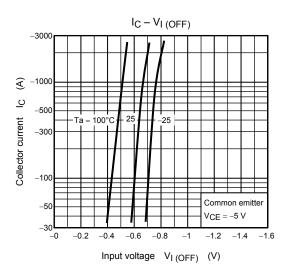
### Q2 (MOS-FET) Electrical Characteristics (Ta = 25°C)

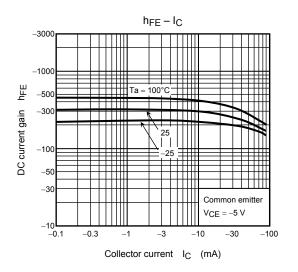
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current	I <sub>GSS</sub>	$V_{GS}=10~V,~V_{DS}=0$	_	_	1	μA
Drain-source breakdown voltage	V (BR) DSS	$I_D = 100 \ \mu A, \ V_{GS} = 0$	20	_	_	V
Drain cut-off current	I <sub>DSS</sub>	$V_{DS} = 20 V, V_{GS} = 0$	_	_	1	μA
Gate threshold voltage	V <sub>th</sub>	$V_{DS} = 3 \text{ V}, \text{ I}_{D} = 0.1 \text{ mA}$	0.5	_	1.5	V
Forward transfer admittance	Y <sub>fs</sub>	$V_{DS} = 3 \text{ V}, \text{ I}_{D} = 10 \text{ mA}$	20	_	_	mS
Drain-source ON resistance	R <sub>DS (ON)</sub>	$I_D = 10 \text{ mA V}_{GS} = 2.5 \text{ V}$	_	20	40	Ω

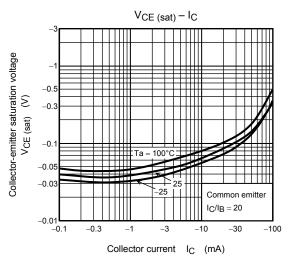
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#### Q1 (Transistor)





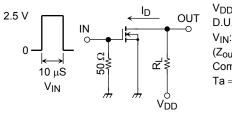




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#### Q2 (MOS-FET)

#### www.(a) Switching time test circuit



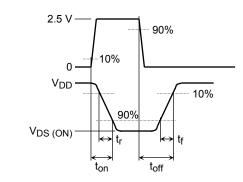
$$\begin{split} & \mathsf{V}_{DD} = 3 \; \mathsf{V} \\ & \mathsf{D}.\mathsf{U}. \leq 1\% \\ & \mathsf{V}_{IN}: \, \mathsf{t}_{\mathsf{f}}, \, \mathsf{t}_{\mathsf{f}} < 5 \; \mathsf{ns} \\ & (\mathsf{Z}_{out} = 50 \; \Omega) \\ & \mathsf{Common \; source} \\ & \mathsf{Ta} = 25^\circ \mathsf{C} \end{split}$$

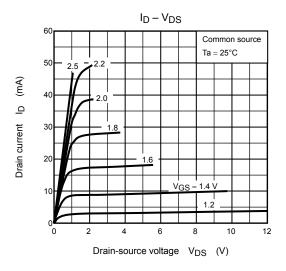
(b) V<sub>IN</sub>

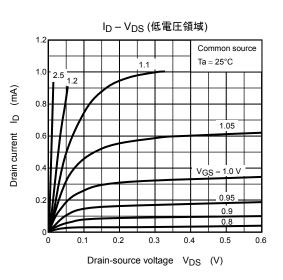
VGS

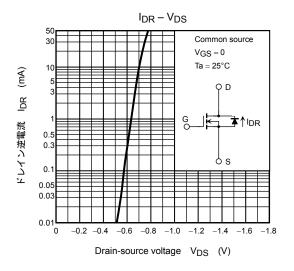
(c) V<sub>OUT</sub>

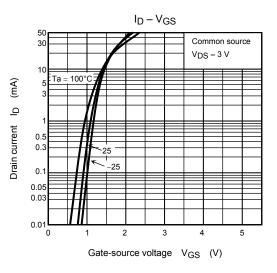
VDS



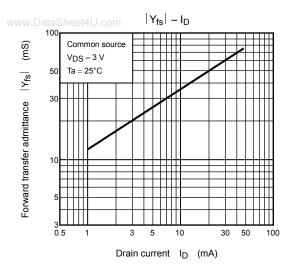


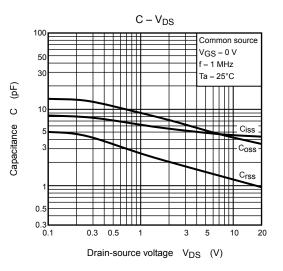


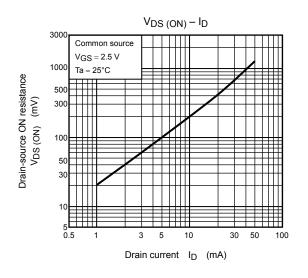


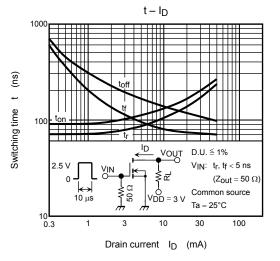


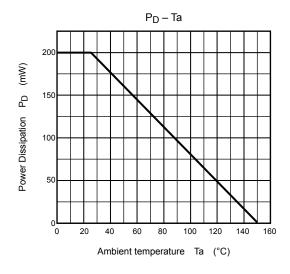
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20070701-EN GENERAL

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